

Notice of References Cited	Application/Control No. 09/527,368	Applicant(s)/Patent Under Reexamination OOTSUKA ET AL.	
	Examiner Michael J. Moyer	Art Unit 2675	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,323,851-B1	11-2001	Nakanishi ✓	345/211
	C	US-6,268,840-B1	07-2001	Huang ✓	345/94
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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